

SEMICONDUCTOR TM

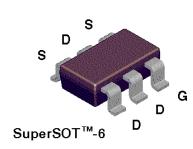
SI3442DV N-Channel Logic Level Enhancement Mode Field Effect Transistor

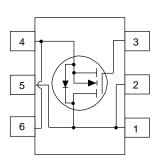
General Description

These N-Channel logic level enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is tailored to minimize on-state resistance. These devices are particularly suited for low voltage applications in notebook computers, portable phones, PCMICA cards, and other battery powered circuits where fast switching, and low in-line power loss are needed in a very small outline surface mount package.

Features

- 4.1 A, 20 V. $R_{DS(ON)} = 0.06 \Omega @ V_{GS} = 4.5 V$ $R_{DS(ON)} = 0.075 \Omega @ V_{GS} = 2.7 V.$
- Proprietary SuperSOTTM-6 package design using copper lead frame for superior thermal and electrical capabilities.
- High density cell design for extremely low R_{DS(ON)}.
- Exceptional on-resistance and maximum DC current capability.





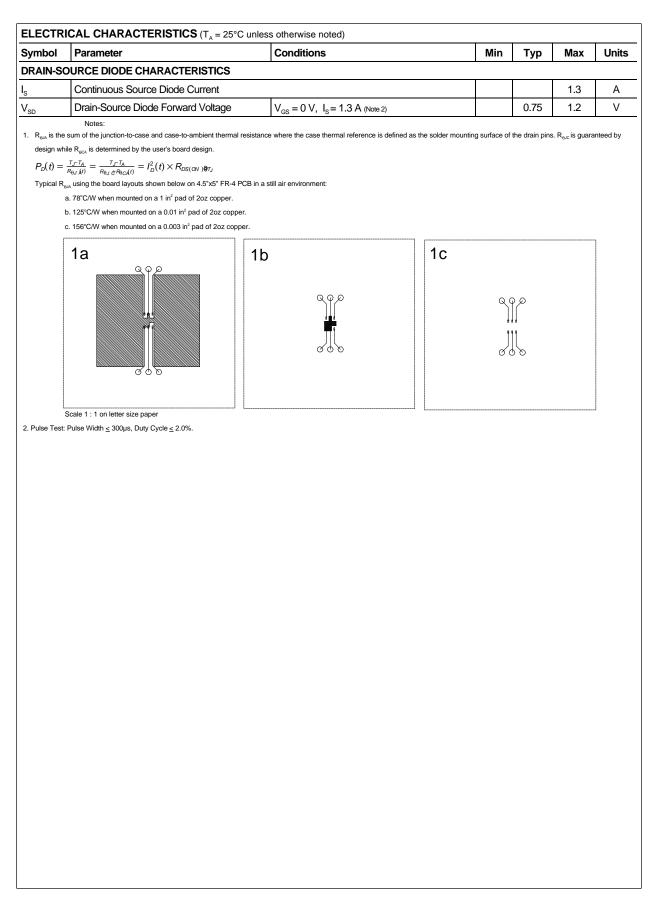
Absolute Maximum Ratings T₄ = 25°C unless otherwise note

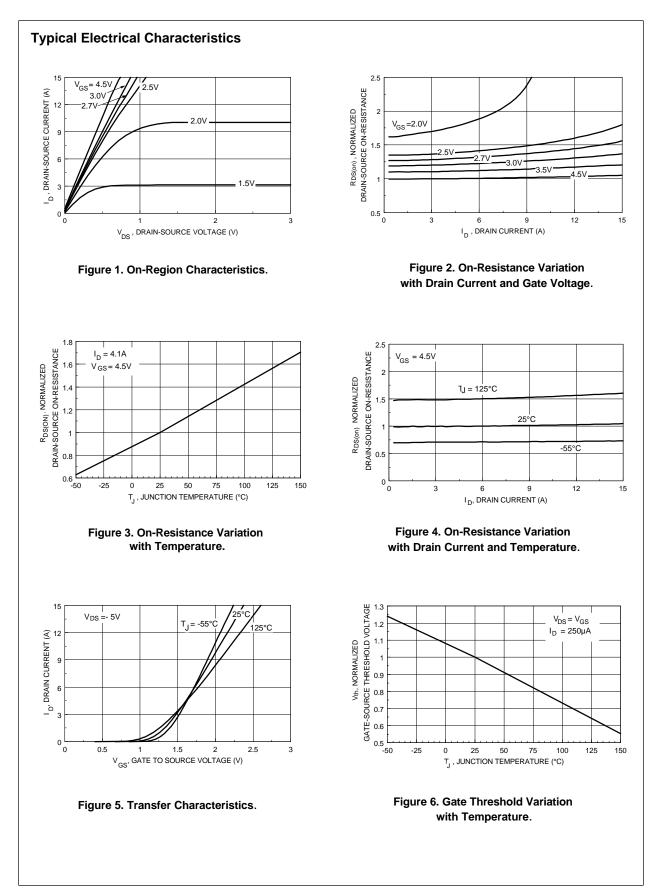
Symbol	Parameter		SI3442DV	
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage - Continuous		8	V
I _D	Drain Current - Continuous	(Note 1a)	4.1	A
	- Pulsed		15	
P _D	Maximum Power Dissipation	(Note 1a)	1.6	W
		(Note 1b)	1	
		(Note 1c)	0.8	
T_,T _{stg}	Operating and Storage Temperature	e Range	-55 to 150	°C
THERMA	L CHARACTERISTICS			
R _{øja}	Thermal Resistance, Junction-to-Ar	nbient (Note 1a)	78	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Ca	ASE (Note 1)	30	°C/W

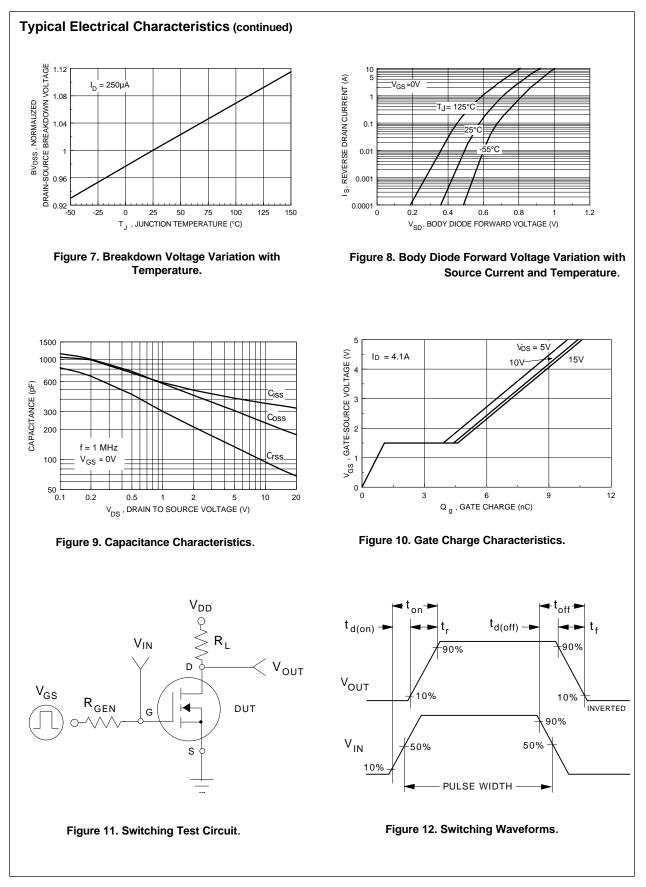
March 2001

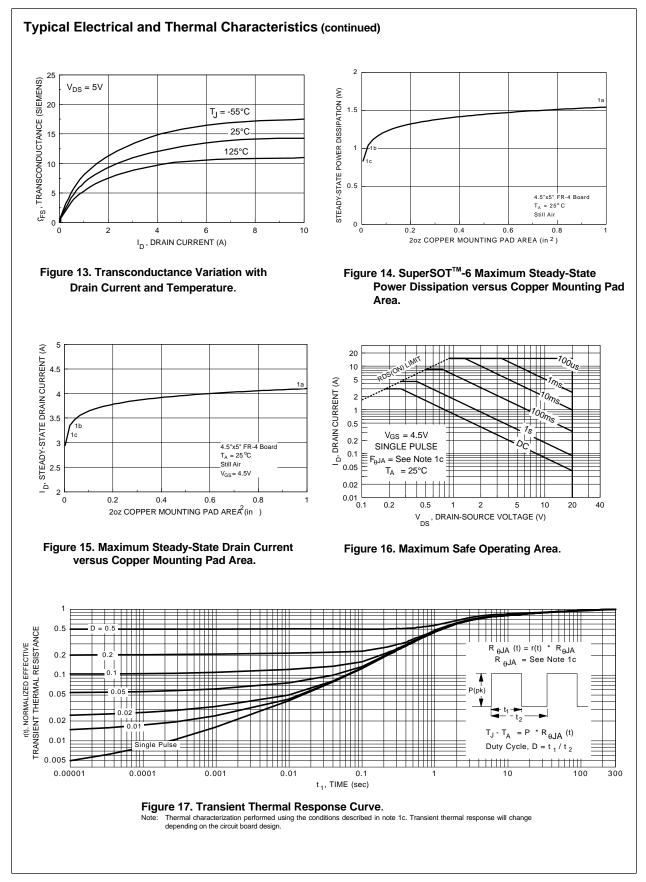
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Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHA	RACTERISTICS						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		20			V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 16 V, V_{GS} = 0 V$				1	μA
			T _J = 55°C			10	μA
I _{GSSF}	Gate - Body Leakage, Forward	$V_{GS} = 8 V, V_{DS} = 0 V$	·			100	nA
I _{GSSR}	Gate - Body Leakage, Reverse	$V_{GS} = -8 V, V_{DS} = 0 V$				-100	nA
ON CHAP	RACTERISTICS (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		0.4	0.7	1	V
			T _J = 125°C	0.3	0.5	0.8	
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_{D} = 4.1 \text{ A}$			0.039	0.06	Ω
			T _J = 125°C		0.06	0.11	
		$V_{GS} = 2.7 \text{ V}, I_{D} = 3.6 \text{ A}$			0.05	0.075	
I _{D(on)}	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$		15			А
9 _{FS}	Forward Transconductance	$V_{DS} = 4.5 \text{ V}, \text{ I}_{D} = 4.1 \text{ A}$			12		S
DYNAMIC	CHARACTERISTICS				-		
C _{iss}	Input Capacitance	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1.0 MHz			365		pF
C _{oss}	Output Capacitance				230		pF
C _{rss}	Reverse Transfer Capacitance				95		pF
SWITCHI	NG CHARACTERISTICS (Note 2)						
t _{D(on)}	Turn - On Delay Time	$V_{DD} = 5 \text{ V}, \text{ I}_{D} = 1 \text{ A},$ $V_{GEN} = 4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega$			9	17	ns
t,	Turn - On Rise Time				25	45	ns
t _{D(off)}	Turn - Off Delay Time				28	50	ns
t _r	Turn - Off Fall Time				8	15	ns
Q _g	Total Gate Charge	$V_{DS} = 10 \text{ V},$ $I_{D} = 4.1 \text{ A}, V_{GS} = 4.5 \text{ V}$			10	14	nC
Q _{gs}	Gate-Source Charge				1		nC
Q_{gd}	Gate-Drain Charge				3.3		nC









SI3442DV Rev.A

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